

1. General Requirements

All components have to be mounted according to the drawing: GBA26800MX
The bare board is specified as: GBA610ADB

2. Revision History

Version	Date	Revised by	Description
1.0	2010-APR-13	A. Tutat	Initial Version
1.1	2010-MAY-28	A. Tutat	some limits adapted, CA47A-000528
1.2	2010-DEC-28	A. Tutat	test cases PTC not required, CA47A-000528
1.3	2011-JAN-06	A. Tutat	SMPS load resistors (2k), CA47A-000528
1.4	2013-JAN-18	A. Tutat	version MX3, MX4 inserted, CN376610
1.5	2014-DEC-15	A. Tutat	Power Supply: IGBT Gate Driver max. voltage changed from 29V to 30V and colour code legend inserted, CN628653
1.6	2015-JUN-12	A. Tutat	SMPS SWITCHING FREQUENCY tolerance increased, CN685046

3. Code Requirements

The board has been laid out according to the requirements in EN81, VDE110-1 (Transient Voltage 4kV; Inhomogeneous Field, Pollution Degree 2 and Safety relevant areas to other areas: Pollution Degree 3; Clearance Distance: Table2; Creepage Distance: Table

Date	Changes	Name	Test Requirement for PBX_BIDI	GBA26800MX_TR		
2015-JUN-12	SMPS SWITCHING FREQUENCY tolerance increased	A. Tutat		12 SHEETS - SHEET 1		
			OTIS Elevator Company Engneering Center Berlin	RESP	2010-APR-13	A. Tutat
				CHK	2010-APR-13	M. Dehmlow
				AUT	2010-APR-13	CA47A-000528

4. Data logging Requirements for the purpose of statistical analysis.

All measurement results should be written together with the PCB serial number and production-date into a file.
The time-interval to produce a back-up of the file should be determined by the factory. Also must be determined how many records are captured per file.

Construction of the file:

1. PCB serial number
2. production-date
3. all measurement results, The variable-names should consist of a combination of Symbol-Name and Parameter-Name.)

Visual separation through special character, for example: *****.

5. Electrical Requirements

Unless otherwise noted MIN/MAX values are valid for temperatures between +0degC and +70degC.
All typical values are calculated for an ambient temperature of Ta=25degC.

DC values have to be measured with an average reading meter. AC values have to be measured with a true-RMS meter.
DC values are marked with the unit V or A, AC values are marked with Vrms or Arms.

The remark "Logic Level" (LL) relates to HCMOS standard: "High" = 3.5V ... 5.7V and "Low"=-0.7V ... 1.0V.

Date	Changes	Name	Test Requirement for PBX_BIDI	GBA26800MX_TR		
2015-JUN-12	SMPS SWITCHING FREQUENCY tolerance increased	A. Tutat		12 SHEETS - SHEET 2		
			OTIS Elevator Company Engneering Center Berlin	RESP	2010-APR-13	A. Tutat
				CHK	2010-APR-13	M. Dehmlow
				AUT	2010-APR-13	CA47A-000528

5.1. Power supply

If within the test cases no other supply voltages are indicated,
the board has to be supplied with the following voltages:

24V_HL2 +24V / current limitable to max. 500mA at P5.46 (referenced to HL2)
HL2 at P5.44

24V_SE +24V / current limitable to max. 500mA at P1.1 (referenced to 24V_SE_RTN)
24V_SE_RTN at P1.2

24V_SW +24V / current limitable to max. 500mA at P4.1 (referenced to 24V_SW_RTN)
24V_SW_RTN at P4.2

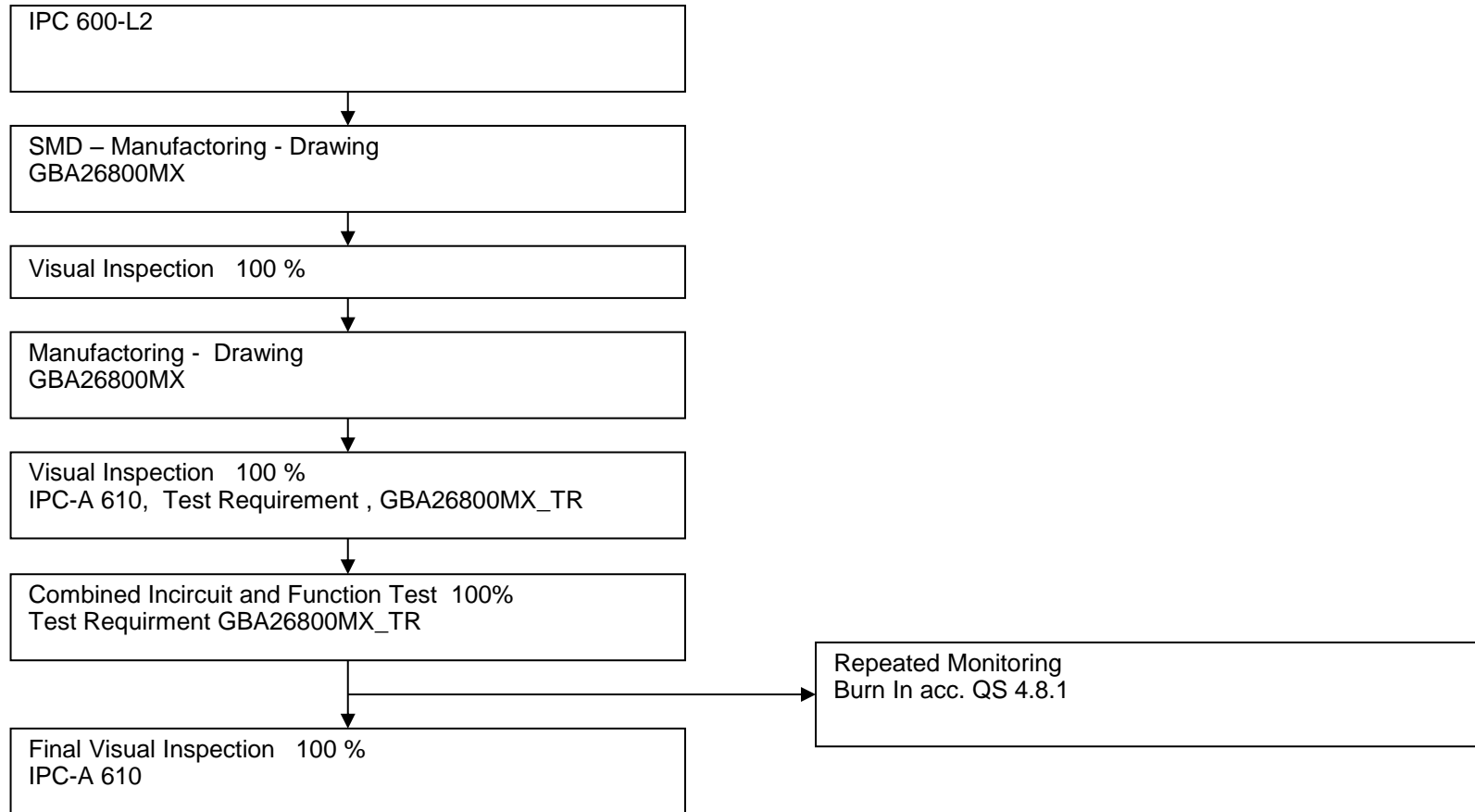
24V_SENSE +24V / current limitable to max. 500mA at P5.50 (referenced to 24V_SENSE_RTN)
24V_SENSE_RTN at P5.48

V+15V +15V / current limitable to max. 200mA at P3.40 (referenced to AGND)
V-15V -15V / current limitable to max. 200mA at P3.39 (referenced to AGND)
AGND at P3.38

VCC +5V / current limitable to max. 200mA at P3.13 (referenced to GND)
GND at P3.12

Date	Changes	Name	Test Requirement for PBX_BIDI	GBA26800MX_TR		
2015-JUN-12	SMPS SWITCHING FREQUENCY tolerance increased	A. Tutat		12 SHEETS - SHEET 3		
			OTIS Elevator Company Enigneering Center Berlin	RESP	2010-APR-13	A. Tutat
				CHK	2010-APR-13	M. Dehmlow
				AUT	2010-APR-13	CA47A-000528

6. Test Flow



Date	Changes	Name	Test Requirement for PBX_BIDI	GBA26800MX_TR		
2015-JUN-12	SMPS SWITCHING FREQUENCY tolerance increased	A. Tutat		12 SHEETS - SHEET 4		
			OTIS Elevator Company Engneering Center Berlin	RESP	2010-APR-13	A. Tutat
				CHK	2010-APR-13	M. Dehmlow
				AUT	2010-APR-13	CA47A-000528

Test Requirement for PBX_BIDI GBA26800MX																	
1. All measuring instruments must be calibrated!!! 2. As an additional document, the circuit diagram of the PCBA is required. 3. All measuring points : reference points are described in kind of netnames, test points or component designator. 4. PBX_BIDI alternatively assembled with CONVERTER- or INVERTER-FUNCTIONALITY test cases only for PBX_BIDI, INVERTER-FUNCTIONALITY , GBA26800MX1, MX3, marked with note: 1 test cases only for PBX_BIDI, CONVERTER-FUNCTIONALITY , GBA26800MX2, MX4, marked with note: 2 test cases not required for GBA26800MX1, MX2, MX3, MX4, marked with note: 4 5. Highly Accelerated Life Test, test cases required for HALT , marked with note: 3						Samples						Value range Lower Specification Limit Upper Specification Limit					
colour code legend						colour code legend						colour code legend					
white: Testcases description, preparation			lightgreen: Measuring points, specified conditions, equations			white: Individual measured value						lightyellow: Allowed value range					
darkgreen: Hardware calibration parameter handling and EEPROM parameter store addresses			lightblue: transfer gain K3 (plausibility) check for HW calibration														
			darkgreen: Hardware calibration relevant measuring points, specified conditions, equations, EEPROM parameter store addresses														
Test cases						Board Serial Number						LSL		Typical		USL	
Description		note	note	measuring point : reference point @ specified condition		unit											
Power Supply: IGBT Gate Driver PHASE R(U)		1		quiescent current consumption: 24V_SW @ 24VDC		mA								180,00	236,00	290,00	
SMPS characteristic		2		quiescent current consumption: 24V_SE @ 24VDC											180,00	236,00	360,00
Switched Mode Power Supply				current: IGBT driver SMPS, SENSING SMPS		V											
				PWM_VCC_RU : 24V_DRIVER_RTN											10,00	11,00	13,00
				I_SENSE_RU : 24V_DRIVER_RTN										0,10	0,60	0,90	
Power Fail Detection				SWITCHING ON-DUTY-CYCLE w/o any additional load		%								5,00	20,00	30,00	
preparation:				SWITCHING FREQUENCY		kHz								85,00	170,00	260,00	
Please add additional load resistors (2k) to:				PWM CONTROLLER output pin or MOSFET DRAIN													
1.)				GATE_SENSE_RU : 24_DRIVER_RTN													
+27V_RU_P : +27V_RU_P_RTN				DRAIN_RU : 24_DRIVER_RTN													
2.)		3		+27V_RU_P : +27V_RU_P_RTN		V								26,00	27,00	30,00	
		3		+27V_RU_N : +27V_RU_N_RTN											26,00	27,00	30,00
				REF_3V9_RU_P : +27V_RU_P_RTN											6,50	7,00	7,50
				REF_2V5_RU_P : +27V_RU_P_RTN											2,38	2,50	2,63
+27V_RU_N : +27V_RU_N_RTN				PF_IGBT threshold voltage											2,00	2,40	3,10
				Increase +27V_RU_P from 0V until output a transition occurs: HIGH to LOW													
				MX1: PF_IGBT_INV : GND													
				MX2: PF_IGBT_CONV : GND													
				preparation:													
				disconnect primary 24V_SW and 24V_SE supply,													
				add an adjustable supply only on													
				+27V_RU_P referenced to +27V_RU_P_RTN													
				REF_3V9_RU_N : +27V_RU_N_RTN											6,50	7,00	7,50
				REF_2V5_RU_N : +27V_RU_N_RTN											2,38	2,50	2,63
				PF_IGBT threshold voltage										2,00	2,40	3,10	
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Test cases										Board Serial Number				LSL		Typical		USL	
Description			note	note	measuring point : reference point @ specified condition			unit											
Power Supply: IGBT Gate Driver PHASE T(W)					PWM_VCC_TW : 24V_DRIVER_RTN			V							10,00	11,00	13,00		
					I_SENSE_TW : 24V_DRIVER_RTN										0,10	0,60	0,90		
SMPS characteristic					SWITCHING ON-DUTY CYCLE w/o any additional load			%							5,00	20,00	30,00		
Switched Mode Power Supply					SWITCHING FREQUENCY										85,00	170,00	260,00		
Power Fail Detection					PWM CONTROLLER output pin or MOSFET DRAIN			kHz											
					GATE_SENSE_TW : 24_DRIVER_RTN														
					DRAIN_TW : 24_DRIVER_RTN														
preparation:			3		+27V_TW_P : +27V_TW_P_RTN			V							26,00	27,00	30,00		
			3		+27V_TW_N : +27V_TW_N_RTN									26,00	27,00	30,00			
Please add additional load resistors (2k) to:					REF_3V9_TW_P : +27V_TW_P_RTN										6,50	7,00	7,50		
					REF_2V5_TW_P : +27V_TW_P_RTN									2,38	2,50	2,63			
1.)					PF_IGBT threshold voltage										2,00	2,40	3,10		
+27V_TW_P : +27V_TW_P_RTN					Increase +27V_TW_P from 0V until output a transition occurs: HIGH to LOW														
2.)					MX1: PF_IGBT_INV : GND														
+27V_TW_N : +27V_TW_N_RTN					MX2: PF_IGBT_CONV : GND														
					preparation:														
					disconnect primary 24V_SW and 24V_SE supply,														
					add an adjustable supply only on														
					+27V_TW_P referenced to +27V_TW_P_RTN														
					REF_3V9_TW_N : +27V_TW_N_RTN										6,50	7,00	7,50		
					REF_2V5_TW_N : +27V_TW_N_RTN										2,38	2,50	2,63		
					PF_IGBT threshold voltage										2,00	2,40	3,10		
					Increase +27V_TW_N from 0V until output a transition occurs: HIGH to LOW														
					MX1: PF_IGBT_INV : GND														
					MX2: PF_IGBT_CONV : GND														
					preparation:														
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					+27V_TW_N referenced to +27V_TW_N_RTN														

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Test cases					Board Serial Number										LSL	Typical	USL			
Description		note	note	measuring point : reference point @ specified condition			unit													
Power Supply: SENSING		1		quiescent current consumption: 24V_SENSE @ 24VDC current: SENSING SMPS			mA											20,00	100,00	200,00
SMPS characteristic				VCC_PWM_CONTROLLER : 24V_SMPS_SENSE_RTN			V											10,00	12,00	15,00
Switched Mode Power Supply				L_SENSE_PWM_CONTROLLER : 24V_SMPS_SENSE_RTN														0,00	0,60	0,90
		1		SWITCHING ON-DUTY-CYCLE PWM CONTROLLER output pin or MOSFET DRAIN SMPS_SENSE_GATE : 24V_SMPS_SENSE_RTN SMPS_SENSE_DRAIN : 24V_SMPS_SENSE_RTN			%											22,00	27,00	32,00
		2		SWITCHING ON-DUTY-CYCLE PWM CONTROLLER output pin or MOSFET DRAIN SMPS_SENSE_GATE : 24V_SMPS_SENSE_RTN SMPS_SENSE_DRAIN : 24V_SMPS_SENSE_RTN			%											22,00	39,00	44,00
				SWITCHING FREQUENCY PWM CONTROLLER output pin or MOSFET DRAIN SMPS_SENSE_GATE : 24V_SMPS_SENSE_RTN SMPS_SENSE_DRAIN : 24V_SMPS_SENSE_RTN			kHz											85,00	170,00	260,00
		3		InvTempUref (Addr.: 0x10) CnvTempUref (Addr.: 0x10) measuring point: S+15V / SGND signal: +15V_SENSE / GND_SENSE			mV											14250,00	15000,00	15750,00
		3		-15V_SENSE : GND_SENSE														-15750,00	-15000,00	-14250,00
Power Supply: PTC Temperature Measurement		4		quiescent current consumption: 24V_HL2 @ 24VDC current: SENSING SMPS			mA											4,00	100,00	200,00
SMPS characteristic				SW_TEMP_SENSOR : HL2			kHz											180,00	200,00	220,00
Switched Mode Power Supply		3		5V_HL2 : HL2														4,75	5,00	5,25
				PTC_ADC: HL2 @ open PTC_1/PTC_6			V											3,00	3,70	5,00
preparation:				PTC_ADC: HL2 @ 1k, 1% resistor between PTC_1/PTC_6														1,00	1,20	1,80
Please connect, the test cases referred resistors between the inputs: PTC_1 and PTC_6				PTC_ADC: HL2 @ SHORT-CIRCUIT PTC_1/PTC_6														0,00	0,32	0,50
				PTC_1 : PTC_6			mA											4,00	4,60	5,60
DC-Link-LED acquisition via a LED sensor				Pilot LED flashing Frequency			Hz											5,00	7,00	15,00
preparation:																				
5VDC supply:																				
DCP_LED referenced to DCN_LED_6 (NE555 Timer-pin1)																				
IGBT Gate Driver voltages				RUP_G11:RUP_E11@PWM_RP, PWM_UP=HIGH:GND														-16,00	-9,50	-5,00
preparation:				RUP_G11:RUP_E11@PWM_RP, PWM_UP=LOW:GND														14,00	15,70	17,00
1.) All drivers must be stimulated such that a connected IGBT would be switched on.				RUN_G21:RUN_E21@PWM_RN, PWM_UN=HIGH:GND														-16,00	-9,50	-5,00
Add an IGBT Gate-Emitter load, a 100nF±10% ceramic or metal foil capacitor must be connected between the measuring points:				RUN_G21:RUN_E21@PWM_RN, PWM_UN=LOW:GND														14,00	15,70	17,00
IGBT Gate to IGBT Emitter				SVP_G11:SVP_E11@PWM_SP, PWM_VP=HIGH:GND														-16,00	-9,50	-5,00
RUP_G11 : RUP_E11, RUN_G21 : RUN_E21				SVP_G11:SVP_E11@PWM_SP, PWM_VP=LOW:GND			V											14,00	15,70	17,00
SVP_G11 : SVP_E11, SVN_G21 : SVN_E21				SVN_G21:SVN_E21@PWM_SN, PWM_VN=HIGH:GND														-16,00	-9,50	-5,00
TWP_G11 : TWP_E11, TWN_G21 : TWN_E21				SVN_G21:SVN_E21@PWM_SN, PWM_VN=LOW:GND														14,00	15,70	17,00
short circuit: IGBT Collector to IGBT Emitter				TWP_G11:TWP_E11@PWM_TP, PWM_WP=HIGH:GND														-16,00	-9,50	-5,00
RUP_C1 : RUP_E11 : RUN_E21				TWP_G11:TWP_E11@PWM_TP, PWM_WP=LOW:GND														14,00	15,70	17,00
SVP_C1 : SVP_E11 : SVN_E21				TWN_G21:TWN_E21@PWM_TN, PWM_WN=HIGH:GND														-16,00	-9,50	-5,00
TWP_C1 : TWP_E11 : TWN_E21				TWN_G21:TWN_E21@PWM_TN, PWM_WN=LOW:GND														14,00	15,70	17,00
2.) only GBA26800MX2																				
OUT_EN_CONV:GND set to HIGH level																				

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Test cases										Board Serial Number						LSL		Typical		USL							
Description				note		note		measuring point : reference point @ specified condition				unit															
DRIVER_RESET_N logic low pulse width Description of the function: HCPL316J FAULT* changes from a high impedance state to a logic low, if the voltage on the HCPL316J DESAT pin exceeding an internal reference voltage of 7.5V while the IGBT is on . HCPL316J FAULT* output remains low until HCPL316J RESET* is brought low. HCPL316J FAULT* output is an open collector which allows the FAULT* outputs from all HCPL-316Js to be connected together in a "wired OR" forming the signals: GBA26800MX1: OCT_INV referenced to GND GBA26800MX2: CNV_OC_FLT referenced to GND When one of the six HCPL316J FAULT* outputs change to low, the HCPL316J RESET* input will change to low after a time delay of the "DRIVER_RESET_N logic low pulse width" preparation: 1.) All drivers must be stimulated such that a connected IGBT would be switched on . PWM_RP= LOW :GND, PWM_UP= LOW :GND PWM_RN= LOW :GND, PWM_UN= LOW :GND PWM_SP= LOW :GND, PWM_VP= LOW :GND PWM_SN= LOW :GND, PWM_VN= LOW :GND PWM_TP= LOW :GND, PWM_WP= LOW :GND PWM_TN= LOW :GND, PWM_WN= LOW :GND 2.) Add an IGBT Gate-Emitter load, a 100nF±10% ceramic or metal foil capacitor must be connected between the measure points: IGBT Gate to IGBT Emitter RUP_G11 : RUP_E11, RUN_G21 : RUN_E21 SVP_G11 : SVP_E11, SVN_G21 : SVN_E21 TWP_G11 : TWP_E11, TWN_G21 : TWN_E21 3.) Realize the following possibility to change between: short circuit / open for approximate 1ms: IGBT Collector to IGBT Emitter RUP_C1 : RUP_E11, RUP_E11 : RUN_E21 SVP_C1 : SVP_E11, SVP_E11 : SVN_E21 TWP_C1 : TWP_E11, TWP_E11 : TWN_E21 4.) only GAA26800MX2 OUT_EN_CONV:GND set to HIGH level stimulation: DESAT pins are executed successively by open only one of the short circuit "IGBT Collector to IGBT Emitter" for approximate 60ms. Keep a wait time condition to the next test case of approximate 500ms. All tests must be processed 2 times sequentially, in order to guarantee that no latch up effect appears.						GBA26800MX1: OCT_INV referenced to GND GBA26800MX2: CNV_OC_FLT referenced to GND HIGH pulse width @open <u>only</u> short circuit RUP_C1 : RUP_E11												200		360		500					
						GBA26800MX1: OCT_INV referenced to GND GBA26800MX2: CNV_OC_FLT referenced to GND HIGH pulse width @open <u>only</u> short circuit RUP_E11 : RUN_E21														200		360		500			
						GBA26800MX1: OCT_INV referenced to GND GBA26800MX2: CNV_OC_FLT referenced to GND HIGH pulse width @open <u>only</u> short circuit SVP_C1 : SVP_E11				ms												200		360		500	
						GBA26800MX1: OCT_INV referenced to GND GBA26800MX2: CNV_OC_FLT referenced to GND HIGH pulse width @open <u>only</u> short circuit SVP_E11 : SVN_E21																200		360		500	
						GBA26800MX1: OCT_INV referenced to GND GBA26800MX2: CNV_OC_FLT referenced to GND HIGH pulse width @open <u>only</u> short circuit TWP_C1 : TWP_E11																200		360		500	
		GBA26800MX1: OCT_INV referenced to GND GBA26800MX2: CNV_OC_FLT referenced to GND HIGH pulse width @open <u>only</u> short circuit TWP_E11 : TWN_E21																200		360		500					

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Test cases						Board Serial Number							LSL	Typical	USL				
Description		note	note	measuring point : reference point @ specified condition		unit													
POWER FAIL MONITORING thresholds PFAIL_RS_CONV signal changes from 1.) statical LOW level 2.) TOGGLE between LOW and HIGH 3.) statical HIGH level Umax_line_to_line=480V*1.1 resultant max. voltage range: ±3.7V (Vpp=7.4V) Umin_line_to_line=340V resultant min. voltage: Vpp=4.76V preparation: adjustable sinus voltage supply 7.4Vpp@50Hz, offset=0V to US / GND_SENSE						2		PFAIL_RS_CONV / GND threshold toggle Decrease US from 7.4Vpp until PFAIL_RS_CONV threshold changes from statical LOW to TOGGLE PFAIL_RS_CONV / GND threshold statical LOW Decrease US from 7.4Vpp until PFAIL_RS_CONV threshold changes from TOGGLE to statical HIGH		Vpp							1,00	1,30	4,76
															0,30	0,70	1,00		
Hall Effect Current Sensor LEM: LA200-P TAMURA: S26P200D15Y VAC: T60404-N4646-X201 current conversion ratio: 1:2000 measure the output-current at a given input-current preparation: Apply R=60ohm between: SENSE_IR, SENSE_IU and GNDA SENSE_IS, SENSE_IV and GNDA Input-current source cable put through the hole once. Polarity markings: A positive measuring output-current is obtained on terminal M (pin 2), when the primary input-current flows in the direction of the arrow.								SENSE_IR, SENSE_IU : GNDA output-current @ 0A		mA							-1,00	0,00	1,00
								SENSE_IR, SENSE_IU : GNDA LEM_IR_output-current @ 2A									0,80	1,00	1,20
								SENSE_IR, SENSE_IU : GNDA LEM_IR_output-current @ -2A									-1,20	-1,00	-0,80
								SENSE_IS, SENSE_IV : GNDA LEM_IS_output-current @ 0A									-1,00	0,00	1,00
								SENSE_IS, SENSE_IV : GNDA LEM_IS_output-current @ 2A									0,80	1,00	1,20
								SENSE_IS, SENSE_IV : GNDA LEM_IS_output-current @ -2A									-1,20	-1,00	-0,80
CHG-RELAY contact resistance preparation: OUT_EN_INV:GND set to HIGH level OUT_EN_CONV:GND set to HIGH level REL1, REL2: contacts closed CHRG_N:GND to LOW REL1, REL2: contacts opened CHRG_N:GND to HIGH						2		R_RES:RUO@REL1, REL2: contacts opened		YES or NO							contacts opened		
								R_RES:RUO@REL1, REL2: contacts closed									contacts closed		
								S_RES:SVO@REL1, REL2: contacts opened									contacts opened		
								S_RES:SVO@REL1, REL2: contacts closed									contacts closed		

Test Requirement for PBX_BIDI GBA26800MX																		
1. All measuring instruments must be calibrated!!! 2. As an additional document, the circuit diagram of the PCBA is required. 3. All measuring points : reference points are described in kind of netnames, test points or component designator. 4. PBX_BIDI alternatively assembled with CONVERTER- or INVERTER-FUNCTIONALITY test cases only for PBX_BIDI, INVERTER-FUNCTIONALITY , GBA26800MX1, MX3, marked with note: 1 test cases only for PBX_BIDI, CONVERTER-FUNCTIONALITY , GBA26800MX2, MX4, marked with note: 2 test cases not required for GBA26800MX1, MX2, MX3, MX4, marked with note: 4 5. Highly Accelerated Life Test, test cases required for HALT , marked with note: 3										Samples						Value range Lower Specification Limit Upper Specification Limit		
colour code legend										colour code legend						colour code legend		
white: Testcases description, preparation				lightgreen: Measuring points, specified conditions, equations						white: Individual measured value						lightyellow: Allowed value range		
darkgreen: Hardware calibration parameter handling and EEPROM parameter store addresses				lightblue: transfer gain K3 (plausibility) check for HW calibration														
				darkgreen: Hardware calibration relevant measuring points, specified conditions, equations, EEPROM parameter store addresses														
Test cases										Board Serial Number						LSL	Typical	USL
Description		note	note	measuring point : reference point @ specified condition			unit											
VRS, VST voltage gain calibration and transfer gain K3 (plausibility) check		2		REF_SEC / GNDA (±10%) equation: $5V \cdot 0.4115 \cdot 0.89111 = -1.83356V$			mV									-2017,40	-1834,00	-1650,60
measuring point: DC_VRS / SGND (±10%) signal: VRS_DC_N / GND_SENSE															1852,20	2058,00	2263,80	
measuring point: VRS / AGND (±25%) signal: VRS_OUT_DC_N / GNDA equation: $2.0576V \cdot 0.89111 = 1.8335V$															1375,50	1834,00	2292,50	
measuring point: VRS_N / AGND signal: VRS_OUT_N / GNDA															-1500,00	0,00	1500,00	
transfer gain K3_VRS (plausibility) check proceeding: calculate with the following equation: $K3_VRS = VRS_OUT_DC_N / (0.89111 \cdot VRS_DC_N)$														0,80	1,00	1,10		
measuring point: DC_VST / SGND (±10%) signal: VST_DC_N / GND_SENSE			mV												1852,20	2058,00	2263,80	
measuring point: VST / AGND (±25%) signal: VST_OUT_DC_N / GNDA equation: $2.0576V \cdot 0.89111 = 1.8335V$															1375,50	1834,00	2292,50	
measuring point: VST_N / AGND signal: VST_OUT_N / GNDA															-1500,00	0,00	1500,00	
transfer gain K3_VST (plausibility) check proceeding: calculate with the following equation: $K3_VST = VST_OUT_DC_N / (0.89111 \cdot VST_DC_N)$														0,80	1,00	1,10		
IGBT TEMPERATURE MEASUREMENT and transfer gain K3 (plausibility) check				NTC1:NTC2 (1.86V±10%) measuring point: TEMP_IGBT / GNDA signal: TEMP_IGBT / GNDA equation: typical: $(3.107V \cdot 0.89111) - 0.7258 = 2.04V$ with gain range IL300: 0.8..1.2 min.: $(0.8 \cdot 2.77V) - 0.7258 = 1.49V$ (-3% = 1.445V) max.: $(1.2 \cdot 2.77V) - 0.7258 = 2.6V$ (+3% = 2.68V)			mV									1670,00	1860,00	2050,00
preparation: measure with connected resistor 5kohm, ±0.1% between NTC1 / NTC2																1445,00	2040,00	2680,00
InvTempUn (Addr.: 0x12) CnvTempUn (Addr.: 0x12) measuring point: TEMP_UN / GNDA signal: TEMP_UN / GNDA InvTempUin (Addr.: 0x14) CnvTempUin (Addr.: 0x14) preparation: measure with connected resistor 5kohm between NTC1 / NTC2 measuring point: NTC1 / SGND signal: NTC1 / GND_SENSE																1080,00	1200,00	1320,00
transfer gain K3_TEMP (plausibility) check proceeding: calculate with the following equation: $K3_TEMP = (TEMP_IGBT + (TEMP_UN \cdot 0.604)) / (NTC1 \cdot 0.89111)$																2950,00	3110,00	3270,00
DC-LINK VOLTAGE MEASUREMENT and transfer gain K3 (plausibility) check		1		InvUdcUin (Addr.: 0x18) measuring point: DC_ME / GND_SENSE signal: DC_ME / GND_SENSE equation: typical: $1.2V \cdot 2.4864 = 3V$ InvUdcUout (Addr.: 0x1A) measuring point: UDCL / GNDA signal: UDCL / GNDA equation: typical: $3V \cdot 0.89111 = 2.673V$ with gain range IL300: 0.8..1.2 min.: $0.8 \cdot 2.673V = 2.138V$ (-3% = 2.07V) max.: $1.2 \cdot 2.673V = 3.208V$ (+3% = 3.22V)			mV									2900,00	3000,00	3100,00
preparation: 1.) CALIBRATED precision DC voltage reference OUTPUT VOLTAGE: +1.2V ±0.2% max LOW NOISE: 10µVPP max (0.1Hz to 10Hz) conected to DCP_U_ME_1 / GND_SENSE																2070,00	2673,00	3220,00
2.) short circuit is needed between DCN_U_ME_1 / GND_SENSE				transfer gain K3_UDC (plausibility) check proceeding: calculate with the following equation: $K3_UDC = UDCL / (0.89111 \cdot DC_ME)$												0,80	1,00	1,10

Test Requirement PBX_BIDI

GBA26800MX_TR

12 SHEETS - SHEET 12